CORNERSTONE STANDARD COMPONENTS LIBRARY (On SOI Platforms)







Preface

In this document, we summarise the up-to-date designs and their measurement results of our CORNERSTONE standard components on SOI platforms, at the same time we are optimising the current designs, adding in new designs, and gathering more measurement results. Most of the dimensions are given in this document, whilst a few of them are not. Thus, please use this document together with our up-to-date GDS library which can be downloaded at <u>https://www.cornerstone.sotonfab.co.uk/mpw-design-rules/process-design-kit-pdk</u>.

CORNERSTONE provides an MPW service on three SOI platforms, 220 nm, 340 nm and 500 nm, based on which we provide our standard components. On the 220 nm and 340 nm platforms, we have two waveguide etching depths in addition to a grating etch and we provide standard components working at 1550 nm and 1310 nm. On the 500 nm platform, we have only one waveguide etching depth in addition to a grating etch and we provide standard components are based on TE mode.





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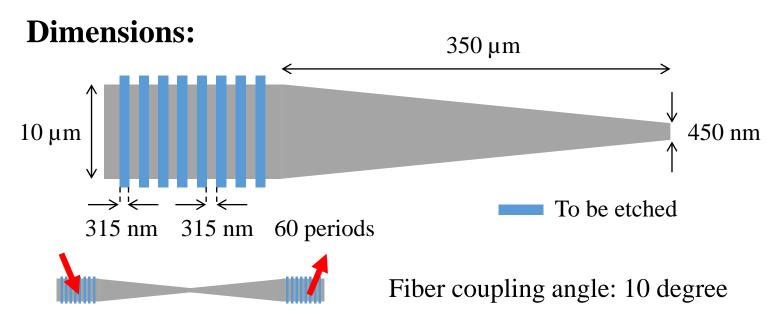
- Wavelength: 1550 nm
- Platform: 220 nm SOI



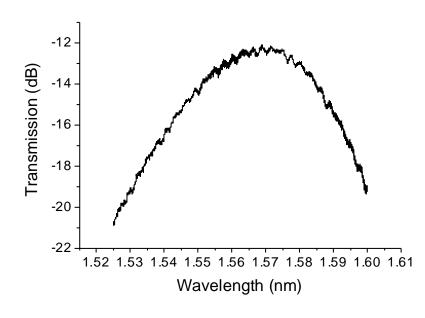


SOI220nm_1550nm_TE_RIB_Grating_Coupler

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|--|
| Wavelength: | 1550 nm |
| Etching depth: | 70 nm (Grating etch depth) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1550nm_TE_RIB_Grating_Coupler |



Measured transmission spectrum



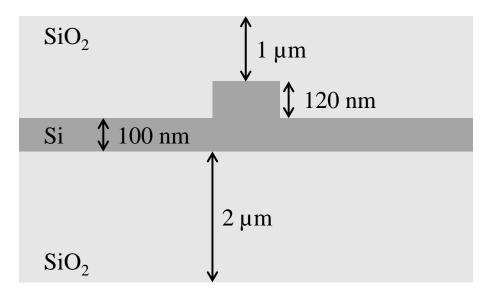
Summarized performance:

- Coupling efficiency: 5.5-6.5 dB
- 1 dB bandwidth:
 > 35 nm
- Center wavelength: 1550-1580 nm





- Wavelength: 1550 nm
- Platform: 220 nm SOI
- RIB



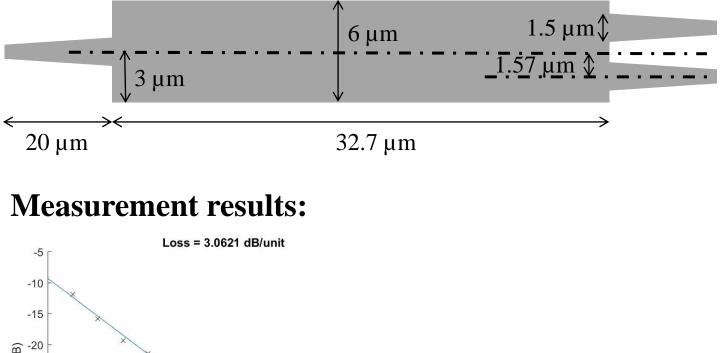


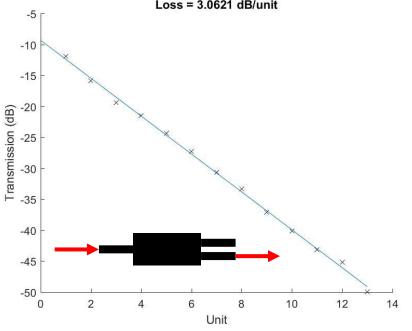


$SOI220nm_1550nm_TE_RIB_2x1_MMI$

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|--------------------------------|
| Wavelength: | 1550 nm |
| Etching depth: | 120 nm (Rib design) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1550nm_TE_RIB_2x1_MMI |

Dimensions:





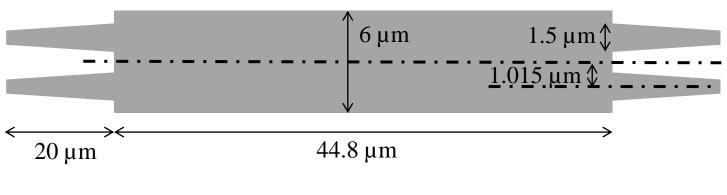




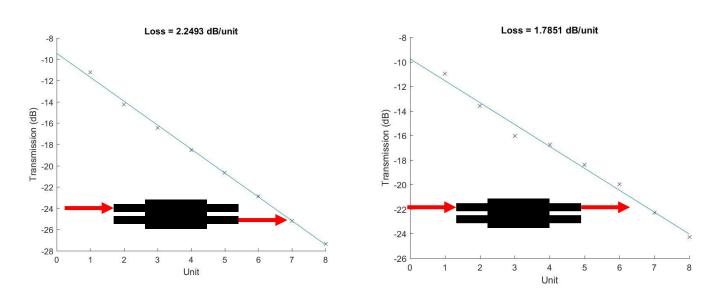
$SOI220nm_1550nm_TE_RIB_2x2_MMI$

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|--------------------------------|
| Wavelength: | 1550 nm |
| Etching depth: | 120 nm (Rib design) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1550nm_TE_RIB_2x2_MMI |

Dimensions:



Measurement results:





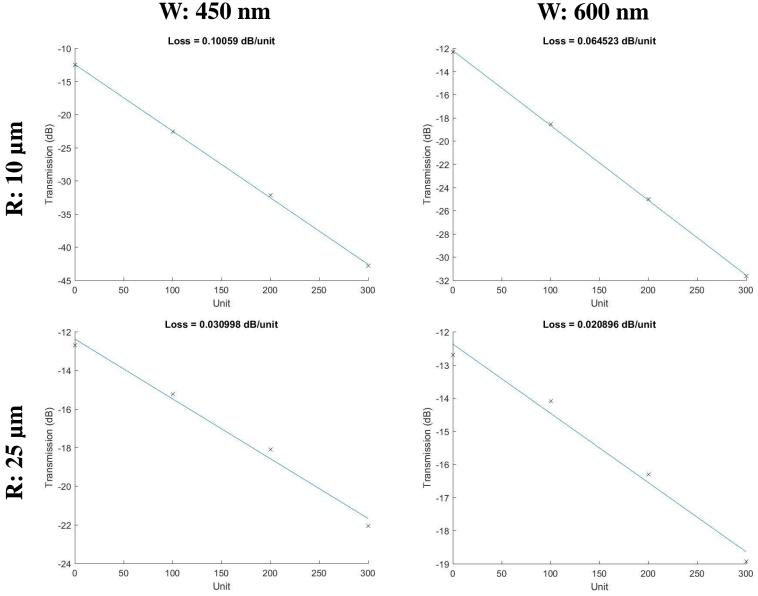


SOI220nm_1550nm_TE_RIB_90_Degree_Bend

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|---|
| Wavelength: | 1550 nm |
| Etching depth: | 120 nm (Rib design) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1550nm_TE_RIB_90_Degree_Bend (Waveguide Width (W): 450 nm, Bend Radius (R): 25 um) |

Measurement results on varied dimensions:

(Unit: 90° bend)







SOI220nm_1550nm_TE_RIB_Waveguide_Crossing

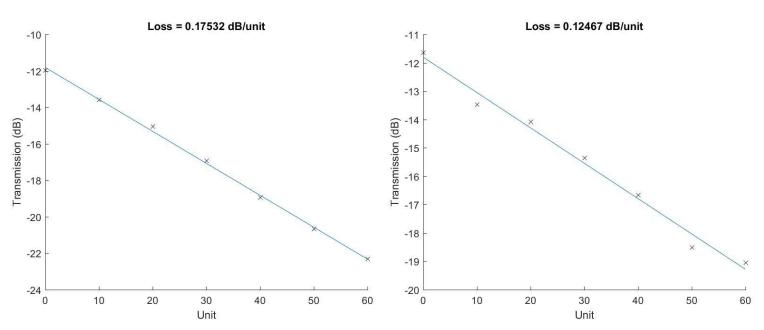
| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|---|
| Wavelength: | 1550 nm |
| Etching depth: | 120 nm (Rib design) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1550nm_TE_RIB_Waveguide_Crossing |

Dimensions: See the drawing in GDS library

Measurement results on different waveguide width (W):



W: 450 nm





-12

-13

-14

-16

-17

-18

-19 L 0

5

10

15

Unit

20

25

30

35

Transmission (dB) -15



SOI220nm_1550nm_TE_RIB_MM to SM_TAPER

| Platform: | 220 nm SOI (2 um BOX layer) |
|---|---|
| Wavelength: | 1550 nm |
| Etching depth: | 120 nm (Rib design) |
| Polarization: | TE |
| Cell name in GDS lib: | Not in GDS library as an individual component. Used together with grating couplers. |
| Dimensions: | L |
| 10 µm | ↓ ↓ 450 nm |
| 115 - | ults on different taper length (L): |
| $\begin{array}{c} -13 \\ \textcircled{\text{Pp}}{\text{P}} \\ -13.5 \\ -13.5 \\ -14 \\ -14 \\ \rule{0ex}{3ex}{3ex}{3ex} \\ -14 \\ \rule{0ex}{3ex}{3ex}{3ex}{3ex} \\ -14 \\ \rule{0ex}{3ex}{3ex}{3ex}{3ex} \\ \rule{0ex}{3ex}{3ex}{3ex}{3ex} \\ \rule{0ex}{3ex}{3ex}{3ex}{3ex}{3ex} \\ \rule{0ex}{3ex}{3ex}{3ex}{3ex}{3ex} \\ \rule{0ex}{3ex}{3ex}{3ex}{3ex}{3ex}{3ex} \\ \rule{0ex}{3ex}{3ex}{3ex}{3ex}{3ex}{3ex} \\ \rule{0ex}{3ex}{3ex}{3ex}{3ex}{3ex}{3ex}{3ex}{3$ | $L: 450 \ \mu m$ |
| | Transmission includes the measurement system loss, grating coupler loss and waveguide loss, as well as |

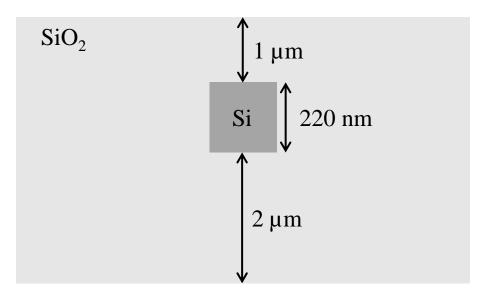
the measured device loss





- Wavelength: 1550 nm
- Platform: 220 nm SOI

• STRIP



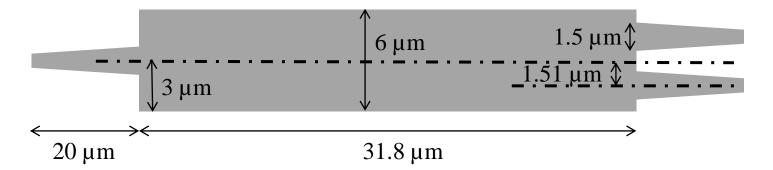




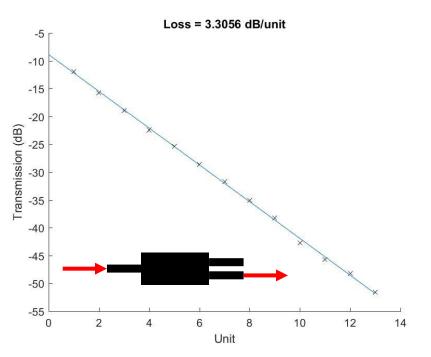
SOI220nm_1550nm_TE_STRIP_2x1_MMI

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|----------------------------------|
| Wavelength: | 1550 nm |
| Etching depth: | 220 nm (Strip design) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1550nm_TE_STRIP_2x1_MMI |

Dimensions:



Measurement results:



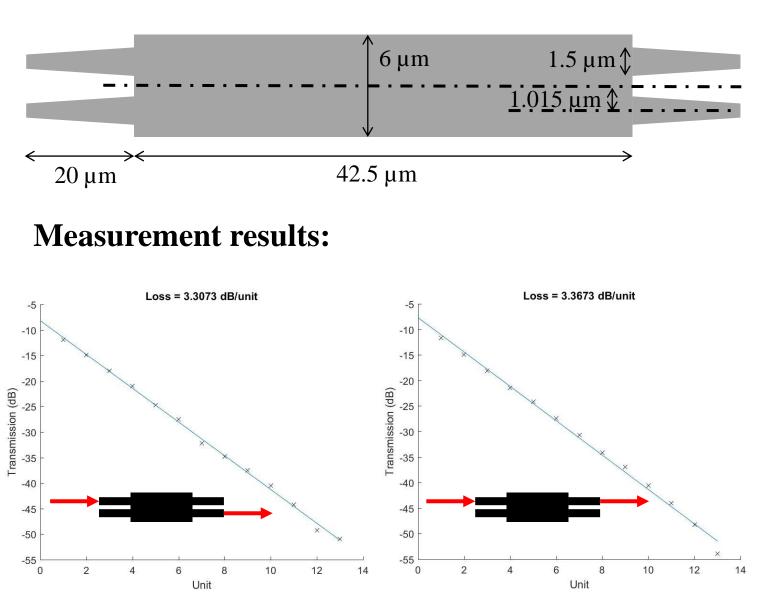




SOI220nm_1550nm_TE_STRIP_2x2_MMI

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|----------------------------------|
| Wavelength: | 1550 nm |
| Etching depth: | 220 nm (Strip design) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1550nm_TE_STRIP_2x2_MMI |

Dimensions:





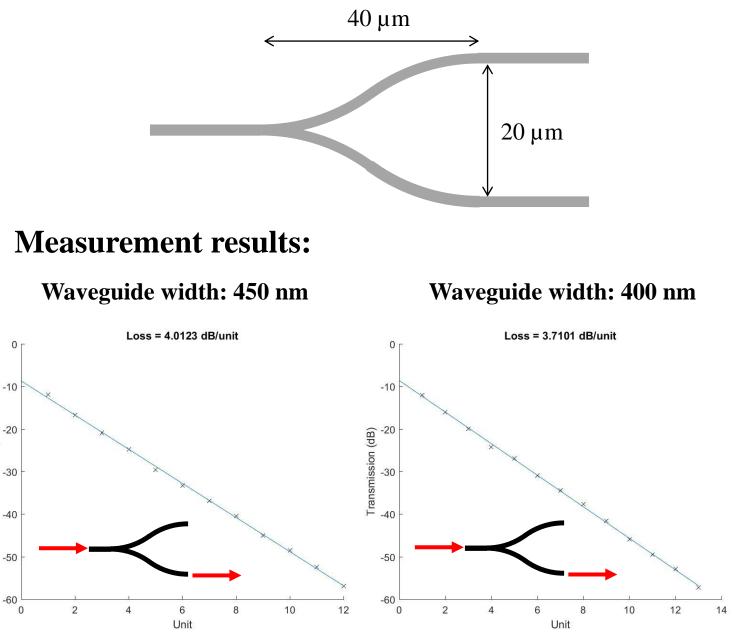


SOI220nm_1550nm_TE_STRIP_2x1_Ysplitter

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|-----------------------------|
| Wavelength: | 1550 nm |
| Etching depth: | 220 nm (Strip design) |
| Polarization: | TE |
| Cell name in GDS lib: | Not in GDS library |

Dimensions:

Transmission (dB)







SOI220nm_1550nm_TE_STRIP_90_Degree_Bend

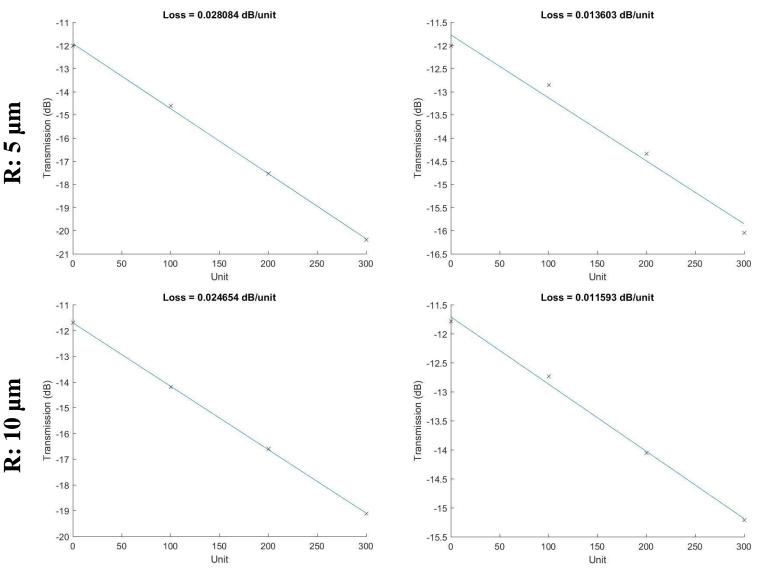
| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|--|
| Wavelength: | 1550 nm |
| Etching depth: | 220 nm (Strip design) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1550nm_TE_STRIP_90_Degree_Bend (Waveguide Width (W): 450 nm, Bend Radius (R): 5 um) |

Measurement results on varied dimensions:

(Unit: 90° bend)

W: 400 nm

W: 450 nm







SOI220nm_1550nm_TE_STRIP_Waveguide_Crossing

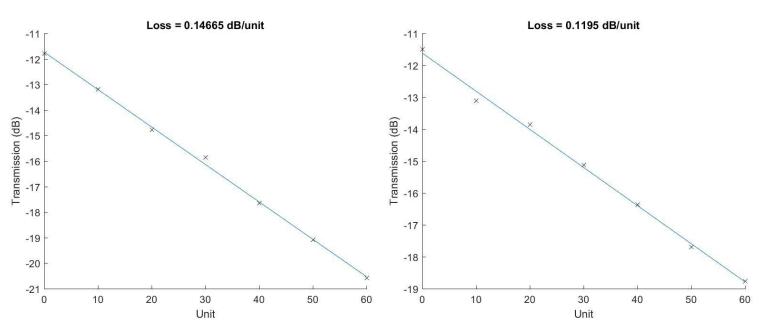
| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|---|
| Wavelength: | 1550 nm |
| Etching depth: | 220 nm (Strip design) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1550nm_TE_STRIP_Waveguide_Crossing |

Dimensions: See the drawing in GDS library

Measurement results on different waveguide width (W):



W: 450 nm





Transmission (dB)

-14.5

-15.5

-16

-16.5

0

5

L: 300 µm

10

15

20

Unit

25

30

35



SOI220nm_1550nm_TE_STRIP_MM to SM_TAPER

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|---|
| Wavelength: | 1550 nm |
| Etching depth: | 220 nm (Strip design) |
| Polarization: | TE |
| Cell name in GDS lib: | Not in GDS library as an individual component. Used together with grating couplers. |
| Dimensions: | L |
| 10 μm | sults on different taper length (L): |
| -12.5 - -13 - | s = 0.11019 dB/unit = 0.11019 dB/unit Loss = 0.14237 dB/unit -12.5 -13 -13.5 -14 -13.5 -14 -15.5 -16 -15.5 -16 -16 -16 -16 -16 -16 -16 -16 |
| .515.516 | L: 450 μ m |

Unit

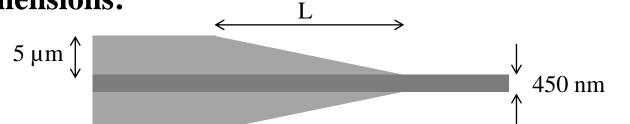




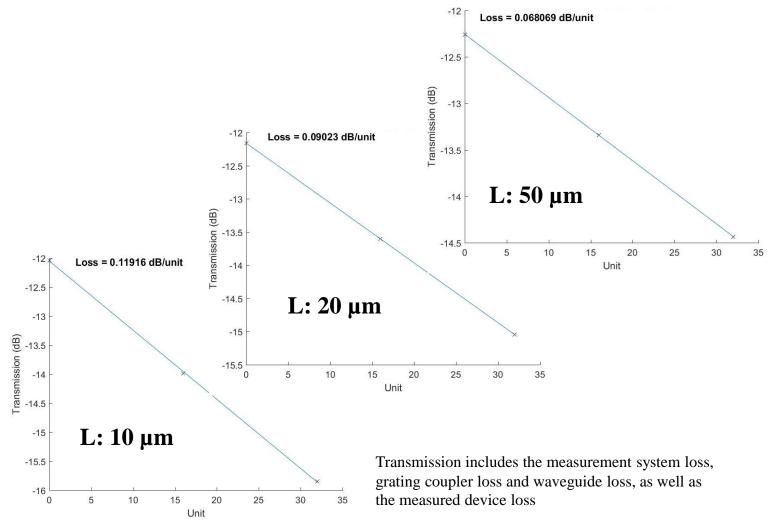
SOI220nm_1550nm_TE_STRIP_RIB to STRIP_TAPER

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|-----------------------------|
| Wavelength: | 1550 nm |
| Etching depth: | 120nm and 220 nm |
| Polarization: | TE |
| Cell name in GDS lib: | Not in GDS library. |

Dimensions:



Measurement results on different taper length (L):







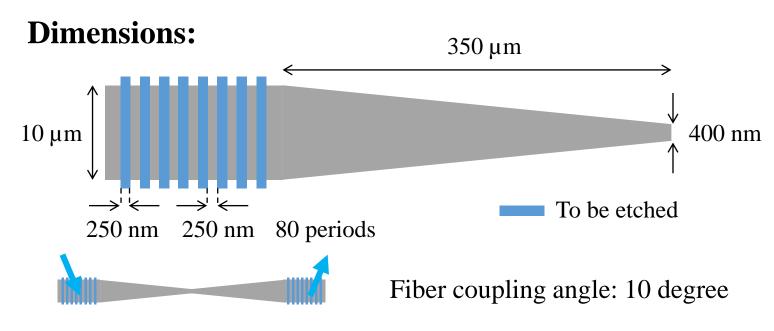
- Wavelength: 1310 nm
- Platform: 220 nm SOI



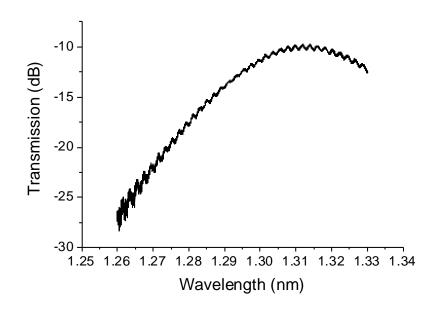


SOI220nm_1310nm_TE_RIB_Grating_Coupler

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|--|
| Wavelength: | 1310 nm |
| Etching depth: | 70 nm (Grating etch depth) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1310nm_TE_RIB_Grating_Coupler |



Measured transmission spectrum



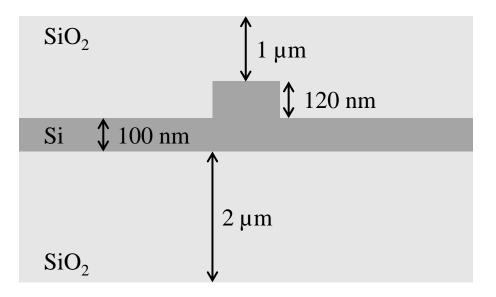
Summarized performance:

- Coupling efficiency: 5-6 dB
- 1 dB bandwidth:
 > 30 nm
- Center wavelength: 1300-1330 nm





- Wavelength: 1310 nm
- Platform: 220 nm SOI
- RIB



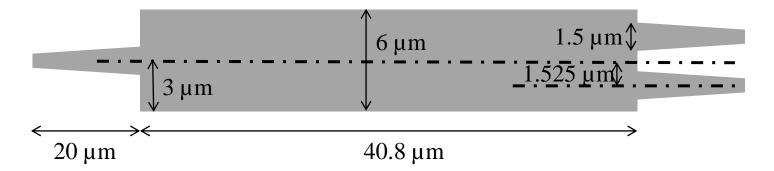




$SOI220nm_1310nm_TE_RIB_2x1_MMI$

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|--------------------------------|
| Wavelength: | 1310 nm |
| Etching depth: | 120 nm (Rib design) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1310nm_TE_RIB_2x1_MMI |

Dimensions:



Measurement results:



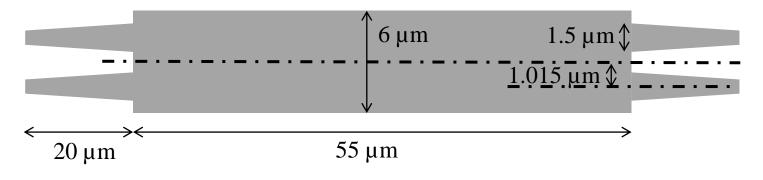




$SOI220nm_1310nm_TE_RIB_2x2_MMI$

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|--------------------------------|
| Wavelength: | 1550 nm |
| Etching depth: | 120 nm (Rib design) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1310nm_TE_RIB_2x2_MMI |

Dimensions:



Measurement results:



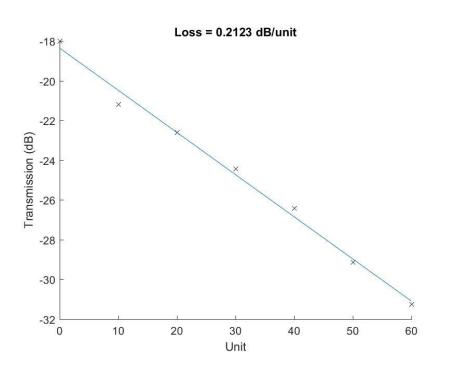


SOI220nm_1310nm_TE_RIB_Waveguide_Crossing

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|---|
| Wavelength: | 1310 nm |
| Etching depth: | 120 nm (Rib design) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1310nm_TE_RIB_Waveguide_Crossing |

Dimensions: See the drawing in GDS library

Measurement results:

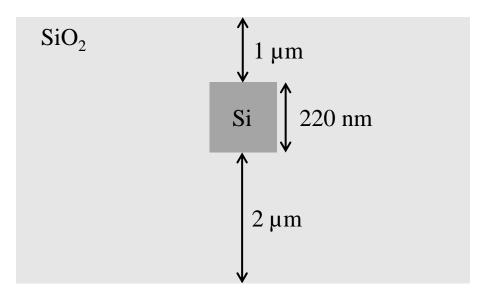






- Wavelength: 1310 nm
- Platform: 220 nm SOI

• STRIP



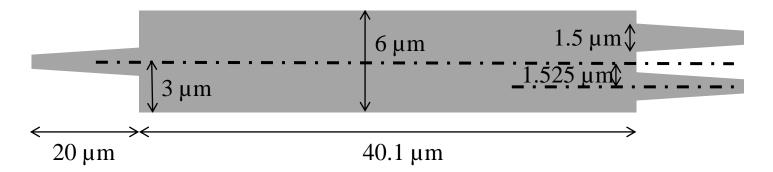




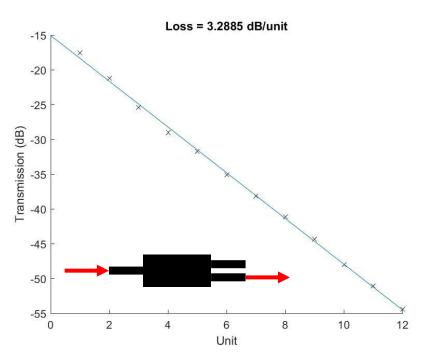
SOI220nm_1310nm_TE_STRIP_2x1_MMI

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|----------------------------------|
| Wavelength: | 1310 nm |
| Etching depth: | 220 nm (Strip design) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1310nm_TE_STRIP_2x1_MMI |

Dimensions:



Measurement results:



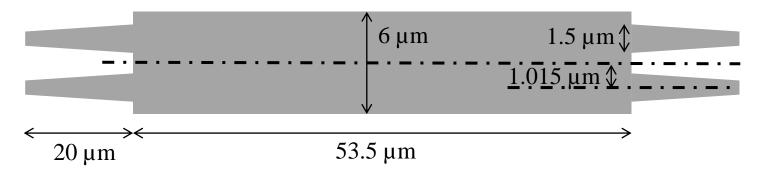




SOI220nm_1310nm_TE_STRIP_2x2_MMI

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|----------------------------------|
| Wavelength: | 1310 nm |
| Etching depth: | 220 nm (Strip design) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1310nm_TE_STRIP_2x2_MMI |

Dimensions:



Measurement results:



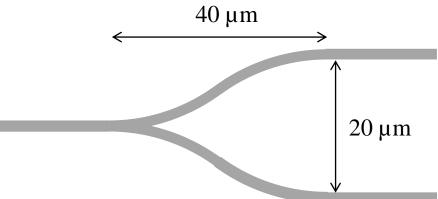




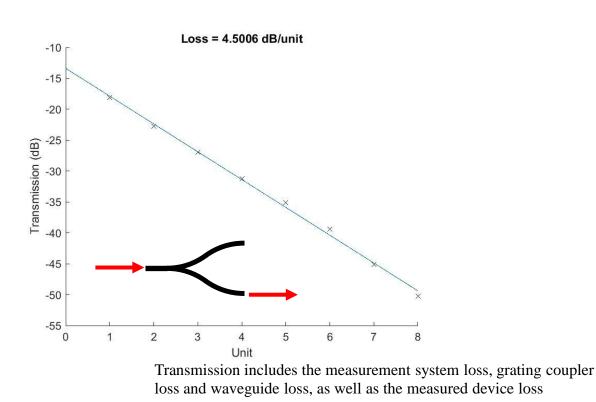
SOI220nm_1310nm_TE_STRIP_2x1_Ysplitter

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|-----------------------------|
| Wavelength: | 1310 nm |
| Etching depth: | 220 nm (Strip design) |
| Polarization: | TE |
| Cell name in GDS lib: | Not in GDS library |

Dimensions:



Measurement results:







SOI220nm_1310nm_TE_STRIP_90_Degree_Bend

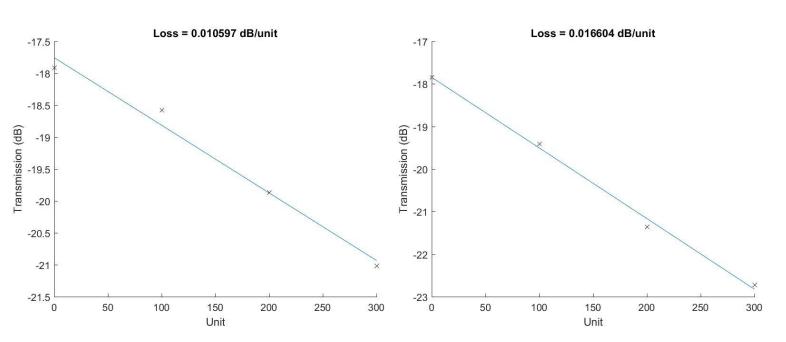
| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|--|
| Wavelength: | 1310 nm |
| Etching depth: | 220 nm (Strip design) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1310nm_TE_STRIP_90_Degree_Bend (Waveguide Width (W): 400 nm, Bend Radius (R): 5 um) |

Measurement results on varied dimensions:

(Unit: 90° bend)



R: 10 µm







SOI220nm_1310nm_TE_STRIP_Waveguide_Crossing

| Platform: | 220 nm SOI (2 um BOX layer) |
|-----------------------|---|
| Wavelength: | 1310 nm |
| Etching depth: | 220 nm (Strip design) |
| Polarization: | TE |
| Cell name in GDS lib: | SOI220nm_1310nm_TE_STRIP_Waveguide_Crossing |

Dimensions: See the drawing in GDS library

Measurement results:

